

<b>Notice of References Cited</b>	Application/Control No. 10/666,235		Applicant(s)/Patent Under Reexamination TERASHI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0006004	01-2003	Fujioka et al.	156/275.7
*	B	US-2002/0134515	09-2002	Yamaguchi et al.	156/379.6
	C	US-			
	D	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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